

FGB20N60SFD 600V, 20A Field Stop IGBT

Features

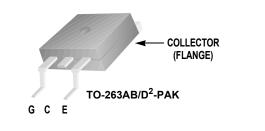
- High Current Capability
- Low Saturation Voltage: V_{CE(sat)} =2.2V @ I_C = 20A
- High Input Impedance
- Fast Switching
- RoHS Compliant

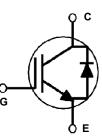
Applications

• Welder, UPS, SMPS, PFC

General Description

Using Novel Field Stop IGBT Technology, Fairchild's new series of Field Stop IGBTs offer the optimum performance for Welder, UPS, SMPS and PFC applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

| Symbol | Description | | Ratings | Units |
|---------------------|--|---------------------------------------|-------------|-------|
| V _{CES} | Collector to Emitter Voltage | | 600 | V |
| V _{GES} | Gate to Emitter Voltage | | ± 20 | V |
| I _C | Collector Current | @ T _C = 25°C | 40 | A |
| | Collector Current | @ T _C = 100°C | 20 | A |
| I _{CM (1)} | Pulsed Collector Current | @ T _C = 25°C | 60 | A |
| I _F | Diode Forward Current | @ T _C = 25°C | 20 | Α |
| | Diode Forward Current | @ T _C = 100 ^o C | 10 | А |
| I _{FM(1)} | Pulsed Diode Maximum Forward Current | | 60 | A |
| P _D | Maximum Power Dissipation | @ T _C = 25°C | 208 | W |
| | Maximum Power Dissipation | @ T _C = 100 ^o C | 83 | W |
| TJ | Operating Junction Temperature | | -55 to +150 | °C |
| T _{stg} | Storage Temperature Range | | -55 to +150 | °C |
| TL | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds | | 300 | °C |

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

October 2010

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Thermal Characteristics

| Symbol | Symbol Parameter | | Max. | Units |
|-------------------------|--|---|------|-------|
| R _{0JC} (IGBT) | Thermal Resistance, Junction to Case | - | 0.6 | °C/W |
| $R_{\theta JC}(Diode)$ | Thermal Resistance, Junction to Case | - | 2.6 | °C/W |
| R_{\thetaJA} | Thermal Resistance, Junction to Ambient (PCB Mount)(2) | - | 40 | °C/W |

Notes: 2: Mounted on 1" square PCB (FR4 or G-10 material)

Package Marking and Ordering Information

| Device Marking | Device | Package | Rel Size | Tape Width | Quantity |
|----------------|-------------|-----------------|----------|------------|----------|
| FGB20N60SFD | FGB20N60SFD | TO-263AB/D2-PAK | 13" Dia | - | 800 |

Electrical Characteristics of the IGBT $T_{C} = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|--|--|---|------|------|------|-------|
| Off Charac | teristics | | | | | |
| BV _{CES} | Collector to Emitter Breakdown Voltage | V _{GE} = 0V, I _C = 250μA | 600 | - | - | V |
| $\frac{\Delta BV_{CES}}{\Delta T_{J}}$ | Temperature Coefficient of Breakdown Voltage | V _{GE} = 0V, I _C = 250μA | - | 0.6 | - | V/ºC |
| I _{CES} | Collector Cut-Off Current | $V_{CE} = V_{CES}, V_{GE} = 0V$ | - | - | 250 | μA |
| I _{GES} | G-E Leakage Current | V_{GE} = V_{GES} , V_{CE} = 0V | - | - | ±400 | nA |
| On Charac | teristics | | | | | |
| V _{GE(th)} | G-E Threshold Voltage | I _C = 250μA, V _{CE} = V _{GE} | 4.0 | 5.0 | 6.5 | V |
| | | I _C = 20A, V _{GE} = 15V | - | 2.2 | 2.8 | V |
| V _{CE(sat)} | Collector to Emitter Saturation Voltage | $I_{C} = 20A, V_{GE} = 15V,$ $T_{C} = 125^{\circ}C$ | - | 2.4 | - | V |
| Dynamic C | haracteristics | | | | | |
| C _{ies} | Input Capacitance | | - | 940 | - | pF |
| C _{oes} | Output Capacitance | V _{CE} = 30V, V _{GE} = 0V, f = 1MHz | - | 110 | - | pF |
| C _{res} | Reverse Transfer Capacitance | | - | 40 | - | pF |
| Switching | Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | | - | 13 | - | ns |
| t _r | Rise Time | | - | 16 | - | ns |
| t _{d(off)} | Turn-Off Delay Time | V _{CC} = 400V, I _C = 20A, | - | 90 | - | ns |
| t _f | Fall Time | R _G = 10Ω, V _{GE} = 15V, | - | 24 | 48 | ns |
| Eon | Turn-On Switching Loss | Inductive Load, $T_C = 25^{\circ}C$ | - | 0.37 | - | mJ |
| E _{off} | Turn-Off Switching Loss | | - | 0.16 | - | mJ |
| E _{ts} | Total Switching Loss | | - | 0.53 | - | mJ |
| t _{d(on)} | Turn-On Delay Time | | - | 12 | - | ns |
| t _r | Rise Time | | - | 16 | - | ns |
| t _{d(off)} | Turn-Off Delay Time | V _{CC} = 400V, I _C = 20A, | - | 95 | - | ns |
| t _f | Fall Time | $R_G = 10\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 125^{\circ}C$ | - | 28 | - | ns |
| E _{on} | Turn-On Switching Loss | | - | 0.4 | - | mJ |
| E _{off} | Turn-Off Switching Loss | | - | 0.28 | - | mJ |
| E _{ts} | Total Switching Loss | | - | 0.69 | - | mJ |

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Electrical Characteristics of the IGBT T_C = 25°C unless otherwise noted

| Qg | Total Gate Charge | | - | 65 | - | nC |
|-----------------|--------------------------|--|---|----|---|----|
| Q _{ge} | Gate to Emitter Charge | V _{CE} = 400V, I _C = 20A, V _{GE} = 15V | - | 7 | - | nC |
| Q _{gc} | Gate to Collector Charge | VGE - 10V | - | 33 | - | nC |

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | | Min. | Тур. | Max | Units |
|-------------------|-------------------------------|--|-------------------------------------|------|------|-----|-------|
| V _{FM} [| Diode Forward Voltage | I _F = 10A | T _C = 25°C | - | 1.9 | 2.5 | V |
| | | | T _C = 125 ^o C | - | 1.7 | - | 1 |
| t _{rr} | Diode Reverse Recovery Time | I _E =10A, dI _E /dt = 200A/μs | T _C = 25 ^o C | - | 34 | - | ns |
| •m | | | T _C = 125°C | - | 57 | - | |
| Q _{rr} | Diode Reverse Recovery Charge | | T _C = 25 ^o C | - | 41 | - | nC |
| | | | T _C = 125 ^o C | - | 96 | - | |

Figure 1. Typical Output Characteristics 60 60 T_C = 125^oC T_C = 25^oC 20V 12V 15V 10V Collector Current, I_c [A] Collector Current, I_c [A] 40 40 20 20 $V_{GE} = 8V$ 0 0 0.0 1.5 3.0 4.5 6.0 0.0 1.5 3.0 Collector-Emitter Voltage, VCE [V] Collector-Emitter Voltage, V_{CE} [V] **Figure 3. Typical Saturation Voltage** Characteristics 60 60 Common Emitter Common Emitter V_{CE} = 20V V_{GE} = 15V T_C = 25°C $T_{C} = 25^{\circ}C_{-}$ Collector Current, I_c [A] Collector Current, I_c [A] T_C = 125°C ... T_C = 125^oC 40 40 20 20 0 0 3 0 2 4 5 4 6 Collector-Emitter Voltage, V_{CE} [V] Figure 5. Saturation Voltage vs. Case **Temperature at Variant Current Level** 4 20 Common Emitter V_{GE} = 15V Collector-Emitter Voltage, V_{CE} [V] Collector-Emitter Voltage, V_{CE} [V] 16 40A 3 12 20A 8 2 I_C = 10A 20Å-I_C = 10A

100

125

4

75

Collector-Emitter Case Temperature, T_c [°C]

Typical Performance Characteristics

Figure 2. Typical Output Characteristics

20V

12V

V_{GE} = 8V

4.5

6.0

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10V

Figure 4. Transfer Characteristics

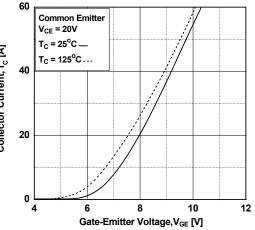
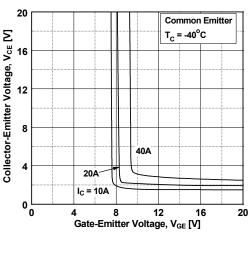


Figure 6. Saturation Voltage vs. V_{GE}



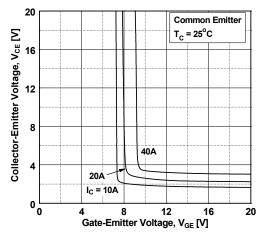
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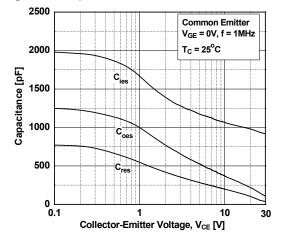
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Typical Performance Characteristics

Figure 7. Saturation Voltage vs. V_{GE}









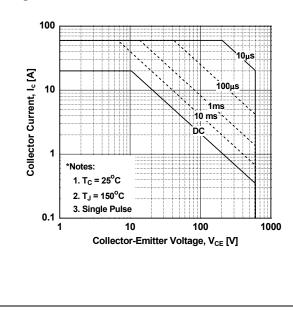


Figure 8. Saturation Voltage vs. V_{GE}

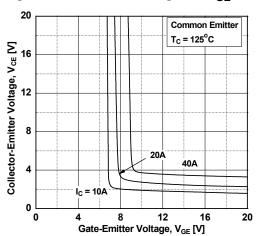


Figure 10. Gate charge Characteristics

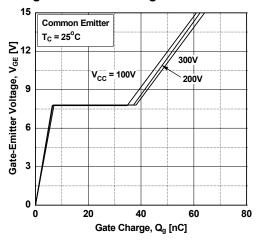
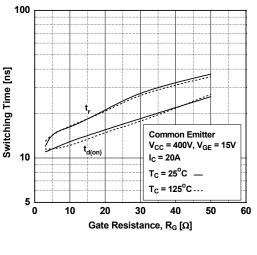
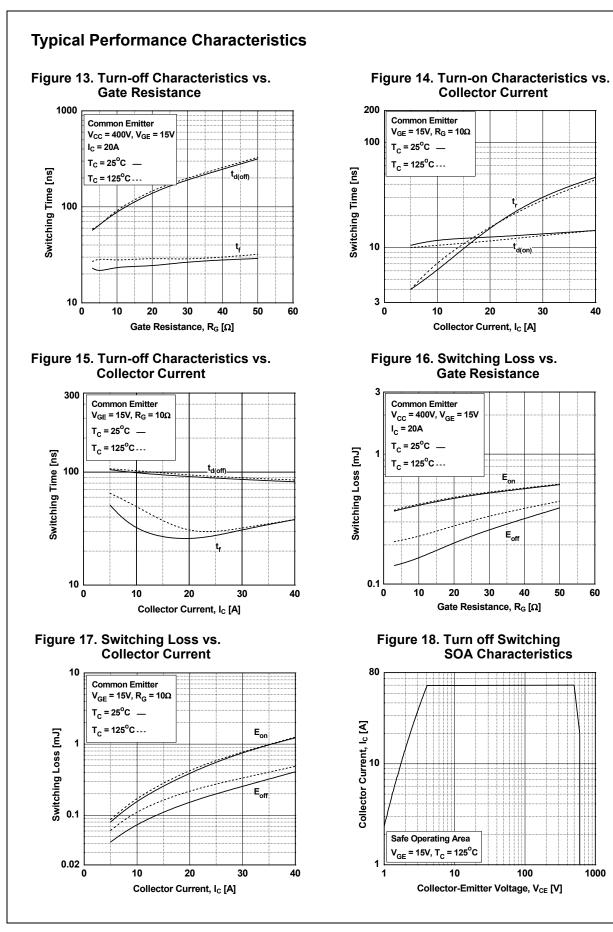


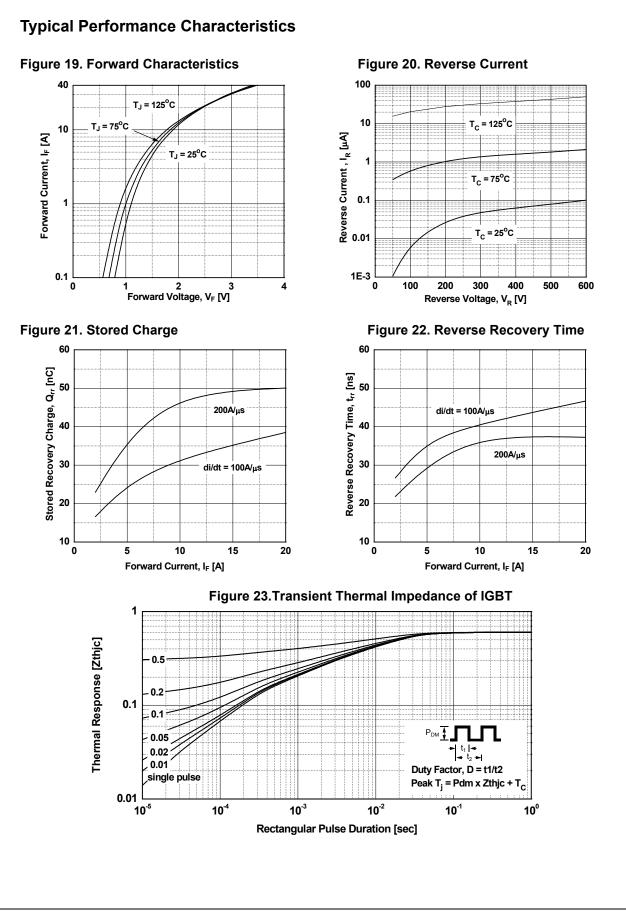
Figure 12. Turn-on Characteristics vs. Gate Resistance

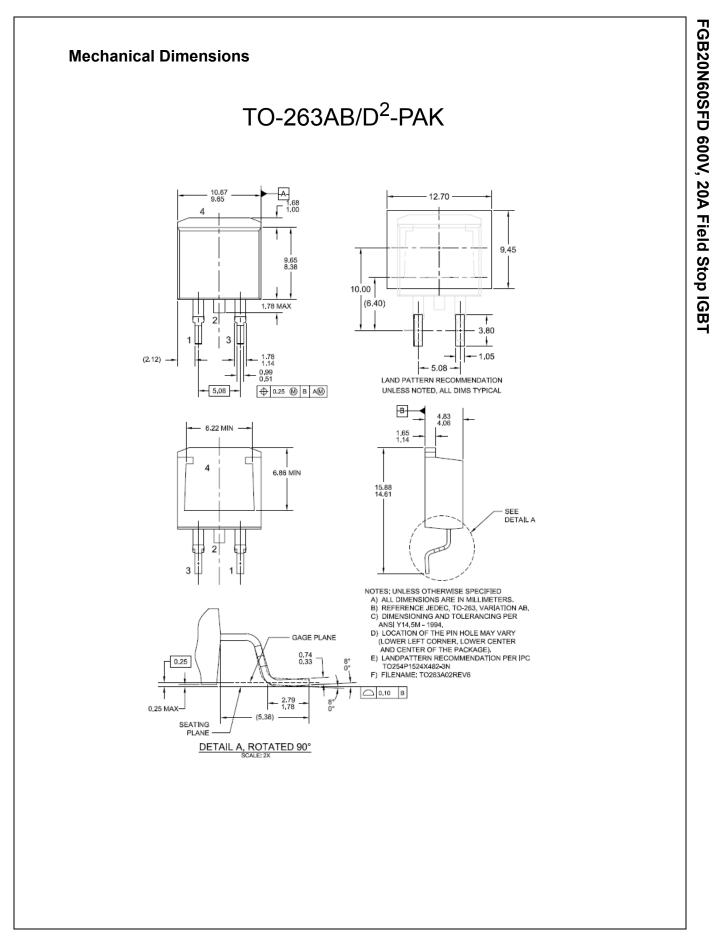


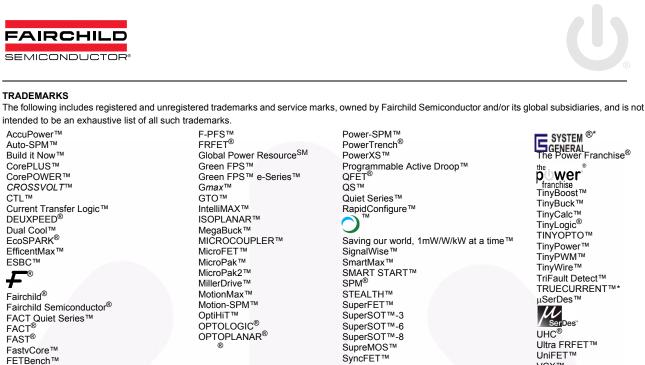
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